

**INFORMATION DISCLOSURE
CITATION IN AN
APPLICATION**

(PTO-1449)

ATTY. DOCKET NO.
HEI-004

U.S. APPLICATION NO.
Not yet assigned

APPLICANT
Tsutomu IWASAKI et al.

FILING DATE

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U.S. PATENT DOCUMENTS

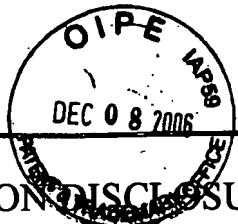
FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
/EL/	0 344 331	12/06/1989	Europe			X	
	1 213 125	06/12/2002	Europe			X	
	04-14430	01/20/1992	Japan			X	
	04-301429	10/26/1992	Japan			X	
	2001-139014	05/22/2001	Japan			X	
	58-89319	05/27/1983	Japan				X
	59-23536	06/02/1984	Japan				X
↓	50-71576	11/07/1973	Japan				X
/E/ /	43-32236	12/27/1968	Japan				X

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER	/Edmund Lee/	DATE CONSIDERED
		10/15/2007

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.



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ATTY. DOCKET NO.
HEI-004

**U.S. PATENT
APPLICATION NO.
10/521,594**

APPLICANT
Tsutomu IWASAKI et al

FILING DATE	GROUP
01/18/2005	1733

U.S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER

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DATE CONSIDERED

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